

74ACT11543  
OCTAL REGISTERED TRANSCEIVER  
WITH 3-STATE OUTPUTS

SCAS136 - D3608, JULY 1990 - REVISED APRIL 1993

- Inputs Are TTL-Voltage Compatible
- 3-State True Outputs
- Back-to-Back Registers for Storage
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V<sub>CC</sub> and GND Configurations Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C

#### description

This 8-bit registered transceiver contains two sets of D-type latches for temporary storage of data flowing in either direction. Separate latch enable (LEAB or LEBA) and output enable (GAB or GBA) inputs are provided for each register to permit independent control in either direction of data flow.

The A-to-B enable (CEAB) input must be low in order to enter data from A or to output data to B. Having CEAB low and LEAB low makes the A-to-B latches transparent; a subsequent low-to-high transition of LEAB puts the A latches in the storage mode. With CEAB and GAB both low, the 3-state B outputs are active and reflect the data present at the output of the A latches. Data flow from B-to-A is similar, but requires the use of CEBA, LEBA, and GBA inputs.

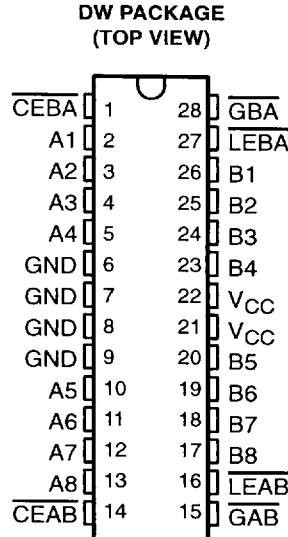
The 74ACT11543 is characterized for operation from – 40°C to 85°C.

FUNCTION TABLE

| INPUTS |      |     | LATCH STATUS<br>A TO B† | OUTPUT BUFFERS<br>B1 THRU B8 |
|--------|------|-----|-------------------------|------------------------------|
| CEAB   | LEAB | GAB |                         |                              |
| H      | X    | X   | Storing                 | Z                            |
| X      | H    |     | Storing                 |                              |
| X      |      | H   |                         | Z                            |
| L      | L    | L   | Transparent             | Current A Data               |
| L      | H    | L   | Storing                 | Previous‡ A Data             |

† A-to-B data flow is shown: B-to-A flow control is the same except uses CEBA, LEBA, and GBA.

‡ Data present before low-to-high transition of LEAB.



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PRODUCTION DATA information is current as of publication date.  
Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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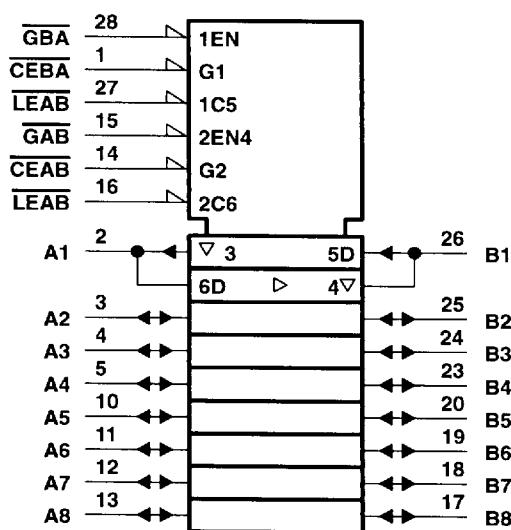
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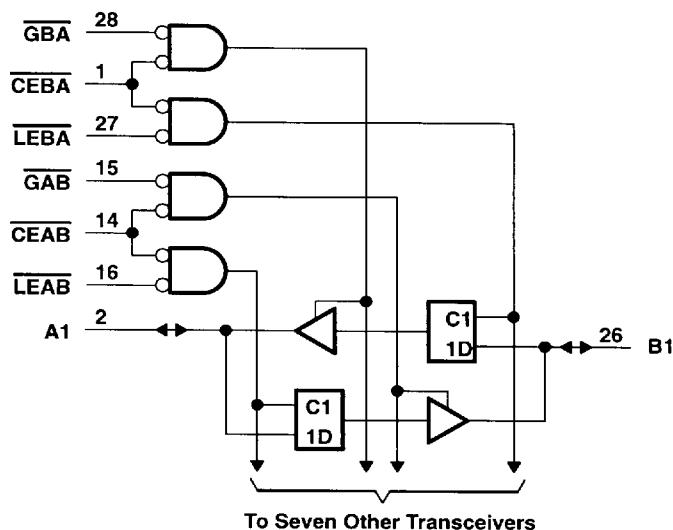
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**logic symbol†**



**logic diagram (positive logic)**



† This symbol is in accordance with ANSI/IEEE Std 91-1984  
 and IEC Publication 617-12.

**absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡**

|  |                            |
|--|----------------------------|
| Supply voltage range, $V_{CC}$ .....                                 | -0.5 V to 7 V              |
| Input voltage range, $V_I$ (see Note 1) .....                        | -0.5 V to $V_{CC} + 0.5$ V |
| Output voltage range, $V_O$ (see Note 1) .....                       | -0.5 V to $V_{CC} + 0.5$ V |
| Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) .....  | $\pm 20$ mA                |
| Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ ) ..... | $\pm 50$ mA                |
| Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ ) .....     | $\pm 50$ mA                |
| Continuous current through $V_{CC}$ or GND .....                     | $\pm 200$ mA               |
| Storage temperature range .....                                      | -65°C to 150°C             |

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

**recommended operating conditions**

|                     |                                    | MIN | NOM      | MAX | UNIT |
|---------------------|------------------------------------|-----|----------|-----|------|
| $V_{CC}$            | Supply voltage                     | 4.5 | 5        | 5.5 | V    |
| $V_{IH}$            | High-level input voltage           | 2   |          |     | V    |
| $V_{IL}$            | Low-level input voltage            |     |          | 0.8 | V    |
| $V_I$               | Input voltage                      | 0   | $V_{CC}$ |     | V    |
| $V_O$               | Output voltage                     | 0   | $V_{CC}$ |     | V    |
| $I_{OH}$            | High-level output current          |     |          | -24 | mA   |
| $I_{OL}$            | Low-level output current           |     |          | 24  | mA   |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | 0   | 10       |     | ns/V |
| $T_A$               | Operating free-air temperature     | -40 | 85       |     | °C   |

**TEXAS**  
**INSTRUMENTS**

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**electrical characteristics over recommended operating free-air temperature range**

| PARAMETER       | TEST CONDITIONS                                     | $V_{CC}$ | $T_A = 25^\circ C$ |      |      | MIN  | MAX  | UNIT |  |
|-----------------|---|----------|--------------------|------|------|------|------|------|--|
|                 |   |          | MIN                | TYP  | MAX  |      |      |      |  |
| $V_{OH}$        | $I_{OH} = -50 \mu A$                                | 4.5 V    | 4.4                |      | 4.4  | 4.4  | 5.4  | V    |  |
|                 |   | 5.5 V    | 5.4                |      | 5.4  |      |      |      |  |
|                 | $I_{OH} = -24 mA$                                   | 4.5 V    | 3.94               |      | 3.8  | 3.8  | 4.8  |      |  |
|                 |   | 5.5 V    | 4.94               |      | 4.8  |      |      |      |  |
| $V_{OL}$        | $I_{OL} = 50 \mu A$                                 | 5.5 V    |                    |      | 3.85 | 3.85 | V    |      |  |
|                 |   | 4.5 V    |                    | 0.1  |      |      | 0.1  |      |  |
|                 | $I_{OL} = 24 mA$                                    | 5.5 V    |                    | 0.1  |      | 0.1  | 0.44 |      |  |
|                 |   | 4.5 V    |                    | 0.36 |      |      |      |      |  |
| $I_I$           | $I_O = 50 \mu A$                                    | 5.5 V    |                    | 0.36 |      | 0.44 | 0.44 | mA   |  |
|                 |   | 5.5 V    |                    | 0.36 |      |      | 1.65 |      |  |
|                 | $I_O = 24 mA$                                       | 5.5 V    |                    |      |      | 1.65 | 0.44 |      |  |
|                 |   | 4.5 V    |                    |      |      |      |      |      |  |
| $I_{IO}$        | $I_O = 75 mA$                                       | 5.5 V    |                    |      |      | 1.65 | 1.65 | mA   |  |
|                 |   | 5.5 V    |                    |      |      |      | 0.1  |      |  |
|                 | $I_O = 0$   | 5.5 V    |                    |      |      | 0.1  | 0.1  |      |  |
|                 |   | 5.5 V    |                    |      |      |      |      |      |  |
| $\Delta I_{CC}$ | One input at 3.4 V, Other inputs at GND or $V_{CC}$ | 5.5 V    |                    | 0.9  |      | 1    | 1    | mA   |  |
|                 |   | 5.5 V    |                    | 0.9  |      |      | 1    |      |  |
|                 | $V_I = V_{CC}$ or GND                               | 5 V      |                    | 4.5  |      | 4.5  | 1    |      |  |
|                 |   | 5 V      |                    | 4.5  |      |      |      |      |  |
| $C_i$           | $V_I = V_{CC}$ or GND                               | 5 V      |                    |      |      | 1    | 1    | pF   |  |
|                 |   | 5 V      |                    |      |      |      |      |      |  |
|                 | $V_O = V_{CC}$ or GND                               | 5 V      |                    | 12   |      | 12   | 12   |      |  |
|                 |   | 5 V      |                    | 12   |      |      |      |      |  |

† Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

‡ For I/O ports, the parameter  $I_{OZ}$  includes the input leakage current.

§ This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or  $V_{CC}$ .

**timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)**

|          |                                  |                           | $T_A = 25^\circ C$ |     | MIN | MAX | UNIT |
|----------|----------------------------------|---------------------------|--------------------|-----|-----|-----|------|
|          |                                  |                           | MIN                | MAX |     |     |      |
| $t_W$    | Pulse duration, LEAB or LEBA low |                           | 4                  | 4   |     |     | ns   |
| $t_{SU}$ | Setup time                       | Data after LEAB or LEBA↑  | 2.5                | 2.5 | 2.5 | 3   | ns   |
|          |                                  | Data before CEAB or CEBA↑ | 3                  | 3   |     |     |      |
| $t_h$    | Hold time                        | Data after LEAB or LEBA↑  | 2                  | 2   | 2   | 1.5 | ns   |
|          |                                  | Data after CEAB or CEBA↑  | 1.5                | 1.5 |     |     |      |



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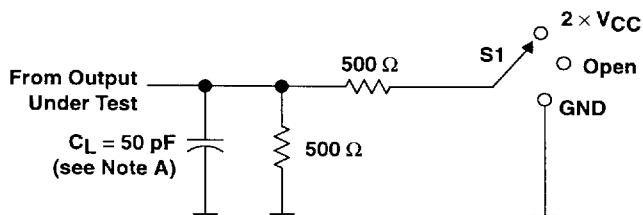
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM<br>(INPUT) | TO<br>(OUTPUT) | TA = 25°C |     |      | MIN | MAX  | UNIT |
|-----------|-----------------|----------------|-----------|-----|------|-----|------|------|
|           |                 |                | MIN       | TYP | MAX  |     |      |      |
| tPLH      | A or B          | B or A         | 3.5       | 6.2 | 9.1  | 3.5 | 10.2 | ns   |
| tPHL      |                 |                | 3.2       | 6.5 | 10.8 | 3.2 | 12.1 |      |
| tPLH      | LEBA or LEAB    | A or B         | 3         | 6.1 | 10.1 | 3   | 11.2 | ns   |
| tPHL      |                 |                | 3.7       | 7.2 | 11.7 | 3.7 | 13.2 |      |
| tPZH      | CEBA or CEAB    | A or B         | 3.5       | 6.7 | 11.1 | 3.5 | 12.2 | ns   |
| tPZL      |                 |                | 3.2       | 8.4 | 13.4 | 3.2 | 16   |      |
| tPHZ      | CEBA or CEAB    | A or B         | 4.8       | 7.3 | 10.1 | 4.8 | 11   | ns   |
| tPLZ      |                 |                | 5.1       | 7.5 | 10.3 | 5.1 | 11.1 |      |
| tPZH      | GBA or GAB      | A or B         | 3.3       | 6.4 | 10.5 | 3.3 | 11.5 | ns   |
| tPZL      |                 |                | 3         | 8   | 12.8 | 3   | 15.3 |      |
| tPHZ      | GBA or GAB      | A or B         | 4.6       | 6.9 | 9.6  | 4.6 | 10.4 | ns   |
| tPLZ      |                 |                | 5         | 7.1 | 9.8  | 5   | 10.5 |      |

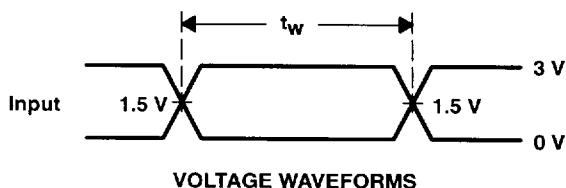
operating characteristics, V<sub>CC</sub> = 5 V, TA = 25°C

| PARAMETER       |   | TEST CONDITIONS  |                                   | TYP | UNIT |
|-----------------|---|------------------|-----------------------------------|-----|------|
| C <sub>pd</sub> | Power dissipation capacitance per transceiver | Outputs enabled  | C <sub>L</sub> = 50 pF, f = 1 MHz | 47  | pF   |
|                 |   | Outputs disabled |                                   | 13  |      |

## PARAMETER MEASUREMENT INFORMATION

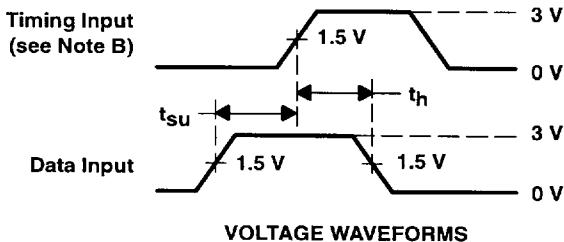


LOAD CIRCUIT

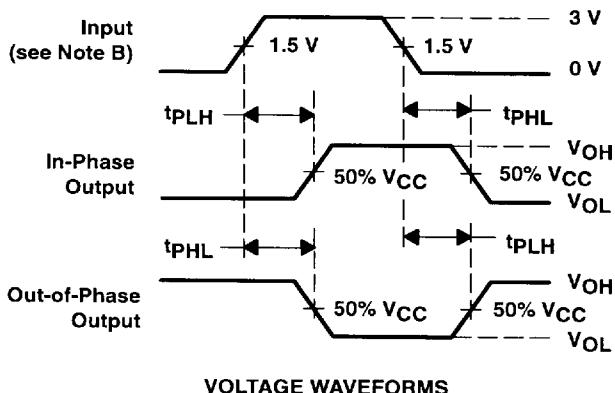


VOLTAGE WAVEFORMS

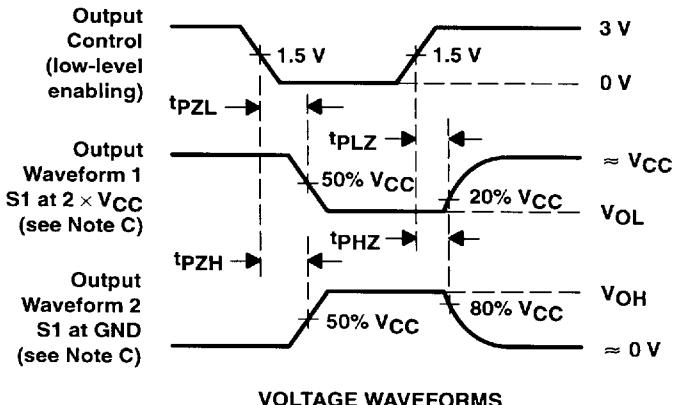
| TEST      | S1      |
|-----------|---------|
| tPLH/tPHL | Open    |
| tPLZ/tPZL | 2 × VCC |
| tPHZ/tPZH | GND     |



VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS

NOTES: A.  $C_L$  includes probe and jig capacitance.

B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r = 3$  ns,  $t_f = 3$  ns.

C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms